

Notice of References Cited	Application/Control No. 10/594,708	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner ROBERT CABRAL	Art Unit 1618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Ishikawa et al., "Structure and electrical properties of Au ₂ S," Solid State Ionics 79 (1995) 60-66
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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